



## &lt; IGBT MODULES &gt;

## CM600DXL-24S

HIGH POWER SWITCHING USE  
INSULATED TYPEMAXIMUM RATINGS ( $T_J=25\text{ }^{\circ}\text{C}$ , unless otherwise specified)

## INVERTER PART IGBT/DIODE

| Symbol            | Item                      | Conditions                                       | Rating   | Unit |
|-------------------|---------------------------|--------------------------------------------------|----------|------|
| $V_{CES}$         | Collector-emitter voltage | G-E short-circuited                              | 1200     | V    |
| $V_{GES}$         | Gate-emitter voltage      | C-E short-circuited                              | $\pm 20$ | V    |
| $I_C$             | Collector current         | DC, $T_C=119\text{ }^{\circ}\text{C}$ (Note2, 4) | 600      | A    |
| $I_{CRM}$         |                           | Pulse, Repetitive (Note3)                        | 1200     |      |
| $P_{tot}$         | Total power dissipation   | $T_C=25\text{ }^{\circ}\text{C}$ (Note2, 4)      | 4545     | W    |
| $I_E$ (Note1)     | Emitter current           | DC (Note2, 4)                                    | 600      | A    |
| $I_{ERM}$ (Note1) |                           | Pulse, Repetitive (Note3)                        | 1200     |      |

## MODULE

| Symbol     | Item                           | Conditions                                      | Rating     | Unit               |
|------------|--------------------------------|-------------------------------------------------|------------|--------------------|
| $V_{isol}$ | Isolation voltage              | Terminals to base plate, RMS, f=60 Hz, AC 1 min | 2500       | V                  |
| $T_{jmax}$ | Maximum junction temperature   | Instantaneous event (overload)                  | 175        | $^{\circ}\text{C}$ |
| $T_{Cmax}$ | Maximum case temperature       | (Note4)                                         | 125        |                    |
| $T_{jop}$  | Operating junction temperature | Continuous operation (under switching)          | -40 ~ +150 | $^{\circ}\text{C}$ |
| $T_{stg}$  | Storage temperature            | -                                               | -40 ~ +125 |                    |

ELECTRICAL CHARACTERISTICS ( $T_J=25\text{ }^{\circ}\text{C}$ , unless otherwise specified)

## INVERTER PART IGBT/DIODE

| Symbol                                | Item                                 | Conditions                                                                                      |                        | Limits |      |      | Unit |
|---------------------------------------|--------------------------------------|-------------------------------------------------------------------------------------------------|------------------------|--------|------|------|------|
|                                       |                                      |                                                                                                 |                        | Min.   | Typ. | Max. |      |
| I <sub>CES</sub>                      | Collector-emitter cut-off current    | V <sub>CE</sub> =V <sub>CES</sub> , G-E short-circuited                                         |                        | -      | -    | 1.0  | mA   |
| I <sub>GES</sub>                      | Gate-emitter leakage current         | V <sub>GE</sub> =V <sub>GES</sub> , C-E short-circuited                                         |                        | -      | -    | 0.5  | μA   |
| V <sub>GE(th)</sub>                   | Gate-emitter threshold voltage       | I <sub>C</sub> =60 mA, V <sub>CE</sub> =10 V                                                    |                        | 5.4    | 6.0  | 6.6  | V    |
| V <sub>CESat</sub><br>(Terminal)      | Collector-emitter saturation voltage | I <sub>C</sub> =600 A, V <sub>GE</sub> =15 V,<br>Refer to the figure of test circuit<br>(Note5) | T <sub>J</sub> =25 °C  | -      | 1.85 | 2.30 | V    |
|                                       |                                      |                                                                                                 | T <sub>J</sub> =125 °C | -      | 2.05 | -    |      |
|                                       |                                      |                                                                                                 | T <sub>J</sub> =150 °C | -      | 2.10 | -    |      |
| V <sub>CESat</sub><br>(Chip)          |                                      | I <sub>C</sub> =600 A,<br>V <sub>GE</sub> =15 V,<br>(Note5)                                     | T <sub>J</sub> =25 °C  | -      | 1.70 | 2.15 | V    |
|                                       |                                      |                                                                                                 | T <sub>J</sub> =125 °C | -      | 1.90 | -    |      |
|                                       |                                      |                                                                                                 | T <sub>J</sub> =150 °C | -      | 1.95 | -    |      |
| C <sub>ies</sub>                      | Input capacitance                    | V <sub>CE</sub> =10 V, G-E short-circuited                                                      |                        | -      | -    | 60   | nF   |
| C <sub>oes</sub>                      | Output capacitance                   |                                                                                                 |                        | -      | -    | 12   |      |
| C <sub>res</sub>                      | Reverse transfer capacitance         |                                                                                                 |                        | -      | -    | 1.0  |      |
| Q <sub>G</sub>                        | Gate charge                          | V <sub>CC</sub> =600 V, I <sub>C</sub> =600 A, V <sub>GE</sub> =15 V                            |                        | -      | 1400 | -    | nC   |
| t <sub>d(on)</sub>                    | Turn-on delay time                   | V <sub>CC</sub> =600 V, I <sub>C</sub> =600 A, V <sub>GE</sub> =±15 V,                          |                        | -      | -    | 800  | ns   |
| t <sub>r</sub>                        | Rise time                            |                                                                                                 |                        | -      | -    | 200  |      |
| t <sub>d(off)</sub>                   | Turn-off delay time                  | R <sub>G</sub> =0 Ω, Inductive load                                                             |                        | -      | -    | 600  |      |
| t <sub>f</sub>                        | Fall time                            |                                                                                                 |                        | -      | -    | 300  |      |
| V <sub>EC</sub> (Note1)<br>(Terminal) | Emitter-collector voltage            | I <sub>E</sub> =600 A, G-E short-circuited,<br>Refer to the figure of test circuit<br>(Note5)   | T <sub>J</sub> =25 °C  | -      | 1.85 | 2.30 | V    |
|                                       |                                      |                                                                                                 | T <sub>J</sub> =125 °C | -      | 1.85 | -    |      |
|                                       |                                      |                                                                                                 | T <sub>J</sub> =150 °C | -      | 1.85 | -    |      |
| V <sub>EC</sub> (Note1)<br>(Chip)     |                                      | I <sub>E</sub> =600 A,<br>G-E short-circuited,<br>(Note5)                                       | T <sub>J</sub> =25 °C  | -      | 1.70 | 2.15 | V    |
|                                       |                                      |                                                                                                 | T <sub>J</sub> =125 °C | -      | 1.70 | -    |      |
|                                       |                                      |                                                                                                 | T <sub>J</sub> =150 °C | -      | 1.70 | -    |      |
| t <sub>rr</sub> (Note1)               | Reverse recovery time                | V <sub>CC</sub> =600 V, I <sub>E</sub> =600 A, V <sub>GE</sub> =±15 V,                          |                        | -      | -    | 300  | ns   |
| Q <sub>rr</sub> (Note1)               | Reverse recovery charge              | R <sub>G</sub> =0 Ω, Inductive load                                                             |                        | -      | 32   | -    | μC   |
| E <sub>on</sub>                       | Turn-on switching energy per pulse   | V <sub>CC</sub> =600 V, I <sub>C</sub> =I <sub>E</sub> =600 A,                                  |                        | -      | 20.3 | -    | mJ   |
| E <sub>off</sub>                      | Turn-off switching energy per pulse  | V <sub>GE</sub> =±15 V, R <sub>G</sub> =0 Ω, T <sub>J</sub> =150 °C,                            |                        | -      | 60.1 | -    |      |
| E <sub>rr</sub> (Note1)               | Reverse recovery energy per pulse    | Inductive load                                                                                  |                        | -      | 69.2 | -    | mJ   |
| R <sub>CC'+EE'</sub>                  | Internal lead resistance             | Main terminals-chip, per switch,<br>T <sub>C</sub> =25 °C (Note4)                               |                        | -      | -    | 0.8  | mΩ   |
| r <sub>g</sub>                        | Internal gate resistance             | Per switch                                                                                      |                        | -      | 3.3  | -    | Ω    |

ELECTRICAL CHARACTERISTICS (cont.; T<sub>j</sub>=25 °C, unless otherwise specified)

## NTC THERMISTOR PART

| Symbol               | Item                    | Conditions                                              | Limits |      |      | Unit |
|----------------------|-------------------------|---------------------------------------------------------|--------|------|------|------|
|                      |                         |                                                         | Min.   | Typ. | Max. |      |
| R <sub>25</sub>      | Zero-power resistance   | T <sub>C</sub> =25 °C (Note4)                           | 4.85   | 5.00 | 5.15 | kΩ   |
| ΔR/R                 | Deviation of resistance | R <sub>100</sub> =493 Ω, T <sub>C</sub> =100 °C (Note4) | -7.3   | -    | +7.8 | %    |
| B <sub>(25/50)</sub> | B-constant              | Approximate by equation (Note6)                         | -      | 3375 | -    | K    |
| P <sub>25</sub>      | Power dissipation       | T <sub>C</sub> =25 °C (Note4)                           | -      | -    | 10   | mW   |

## THERMAL RESISTANCE CHARACTERISTICS

| Symbol                | Item                       | Conditions                                                            | Limits |      |      | Unit |
|-----------------------|----------------------------|-----------------------------------------------------------------------|--------|------|------|------|
|                       |                            |                                                                       | Min.   | Typ. | Max. |      |
| R <sub>th(j-c)Q</sub> | Thermal resistance         | Junction to case, per Inverter IGBT (Note4)                           | -      | -    | 33   | K/kW |
| R <sub>th(j-c)D</sub> |                            | Junction to case, per Inverter DIODE (Note4)                          | -      | -    | 63   | K/kW |
| R <sub>th(c-s)</sub>  | Contact thermal resistance | Case to heat sink, per 1 module,<br>Thermal grease applied (Note4, 7) | -      | 7    | -    | K/kW |

## MECHANICAL CHARACTERISTICS

| Symbol         | Item                   | Conditions                      | Limits |      |      | Unit |
|----------------|------------------------|---------------------------------|--------|------|------|------|
|                |                        |                                 | Min.   | Typ. | Max. |      |
| M <sub>t</sub> | Mounting torque        | Main terminals M 6 screw        | 3.5    | 4.0  | 4.5  | N·m  |
| M <sub>s</sub> |                        | Mounting to heat sink M 5 screw | 2.5    | 3.0  | 3.5  | N·m  |
| m              | mass                   | -                               | -      | 690  | -    | g    |
| d <sub>s</sub> | Creepage distance      | Terminal to terminal            | 13.69  | -    | -    | mm   |
|                |                        | Terminal to base plate          | 15.7   | -    | -    |      |
| d <sub>a</sub> | Clearance              | Terminal to terminal            | 13.69  | -    | -    | mm   |
|                |                        | Terminal to base plate          | 14.88  | -    | -    |      |
| e <sub>c</sub> | Flatness of base plate | On the centerline X, Y (Note8)  | ±0     | -    | +100 | μm   |

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (DIODE).

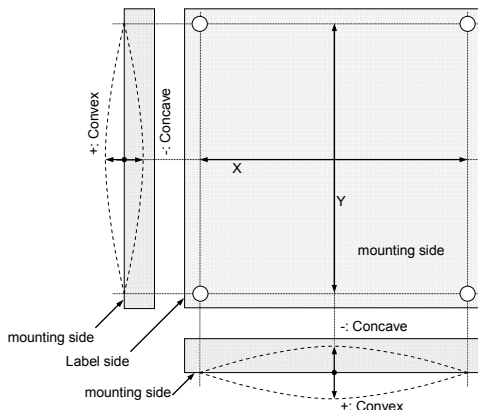
- Junction temperature (T<sub>j</sub>) should not increase beyond T<sub>jmax</sub> rating.
- Pulse width and repetition rate should be such that the device junction temperature (T<sub>j</sub>) dose not exceed T<sub>jmax</sub> rating.
- Case temperature (T<sub>C</sub>) and heat sink temperature (T<sub>s</sub>) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
- Pulse width and repetition rate should be such as to cause negligible temperature rise.  
Refer to the figure of test circuit.

$$6. B_{(25/50)} = \ln \left( \frac{R_{25}}{R_{50}} \right) / \left( \frac{1}{T_{25}} - \frac{1}{T_{50}} \right),$$

R<sub>25</sub>: resistance at absolute temperature T<sub>25</sub> [K]; T<sub>25</sub>=25 [°C]+273.15=298.15 [K]

R<sub>50</sub>: resistance at absolute temperature T<sub>50</sub> [K]; T<sub>50</sub>=50 [°C]+273.15=323.15 [K]

- Typical value is measured by using thermally conductive grease of λ=0.9 W/(m·K).
- The base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.



- Use the following screws when mounting the printed circuit board (PCB) on the stand offs.  
"φ2.6×10 or φ2.6×12 B1 tapping screw"  
The length of the screw depends on the thickness (t1.6~t2.0) of the PCB.

< IGBT MODULES >

# CM600DXL-24S

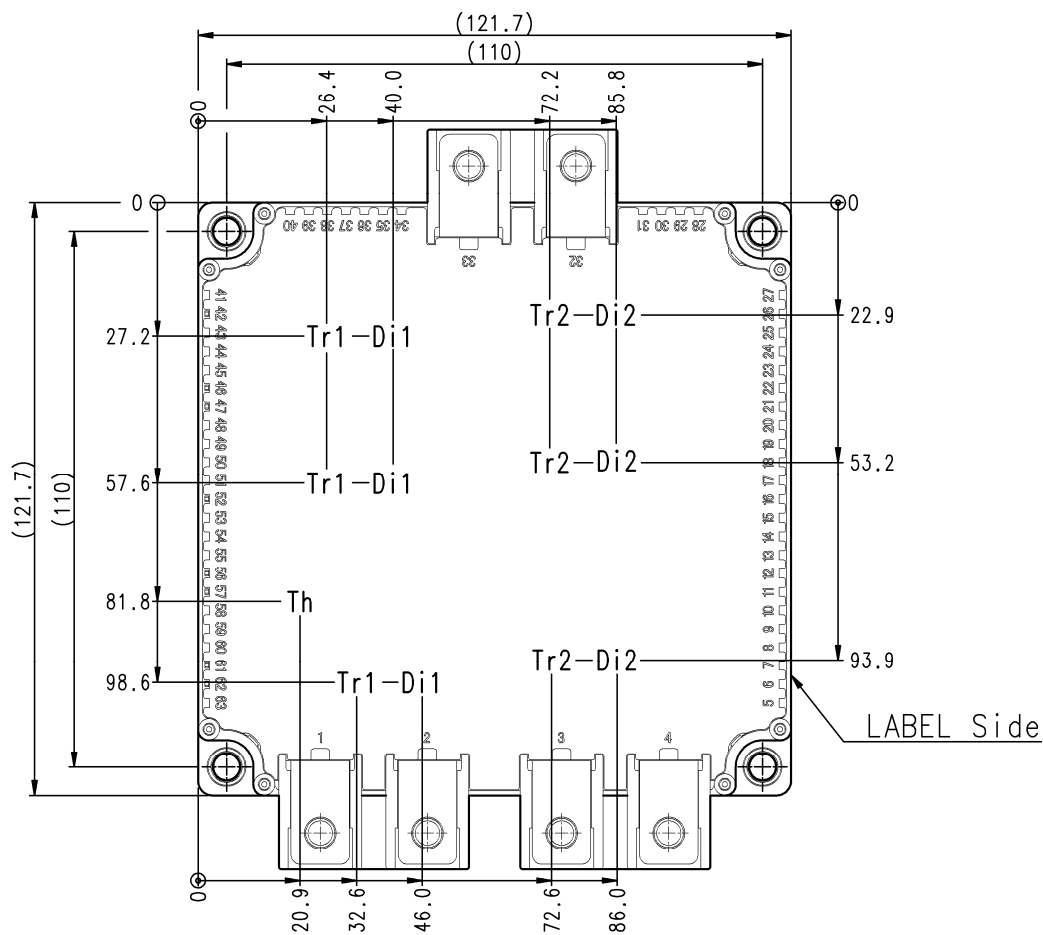
HIGH POWER SWITCHING USE  
INSULATED TYPE

## RECOMMENDED OPERATING CONDITIONS

| Symbol     | Item                          | Conditions                   | Limits |      |      | Unit     |
|------------|-------------------------------|------------------------------|--------|------|------|----------|
|            |                               |                              | Min.   | Typ. | Max. |          |
| $V_{CC}$   | (DC) Supply voltage           | Applied across C1-E2         | -      | 600  | 850  | V        |
| $V_{GEon}$ | Gate (-emitter drive) voltage | Applied across G1-Es1/G2-Es2 | 13.5   | 15.0 | 16.5 | V        |
| $R_G$      | External gate resistance      | Per switch                   | 0      | -    | 6.8  | $\Omega$ |

## CHIP LOCATION (Top view)

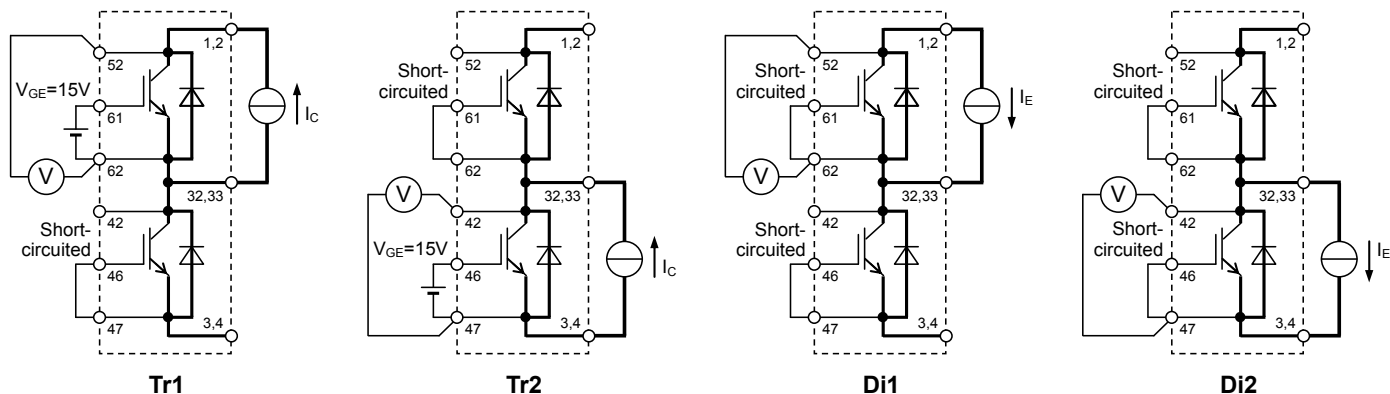
Dimension in mm, tolerance:  $\pm 1$  mm



Tr1/Tr2: IGBT, Di1/Di2: DIODE, Th: NTC thermistor

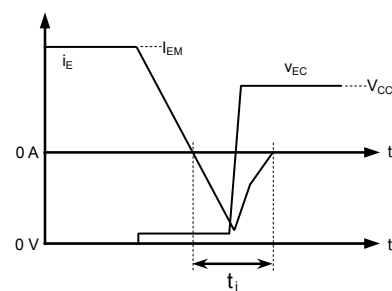
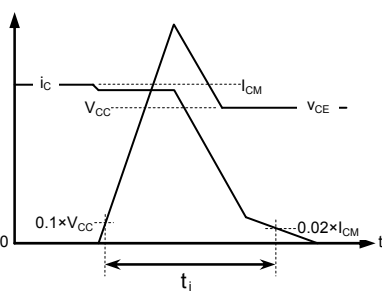
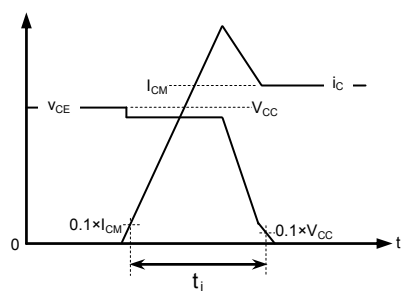
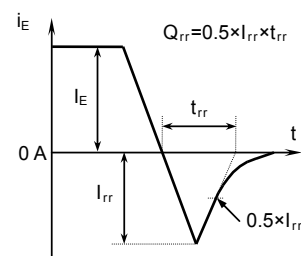
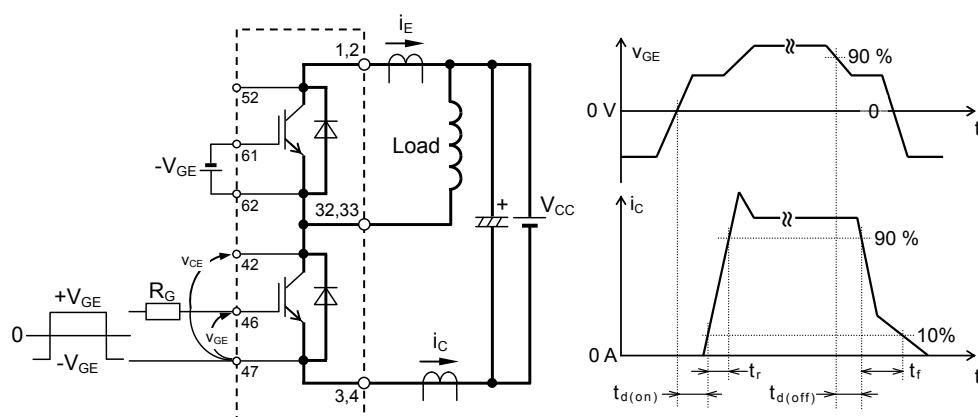
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**CM600DXL-24S**  
HIGH POWER SWITCHING USE  
INSULATED TYPE

**TEST CIRCUIT AND WAVEFORMS**



**$V_{CEsat}$  test circuit**

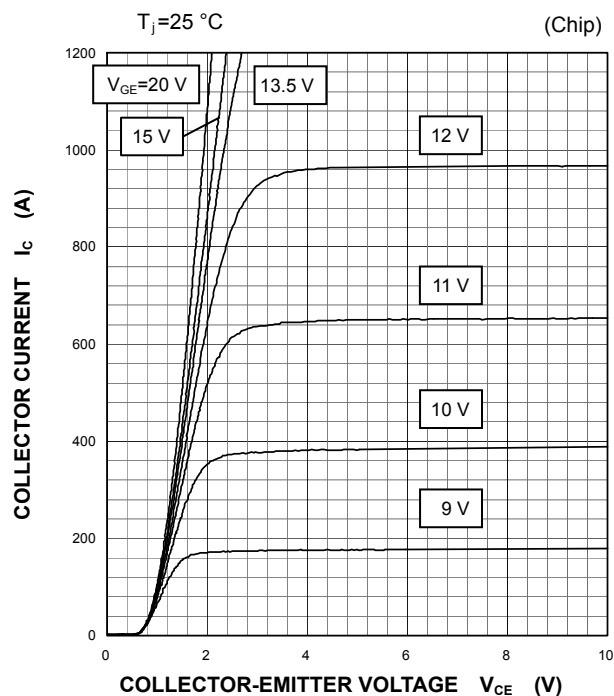
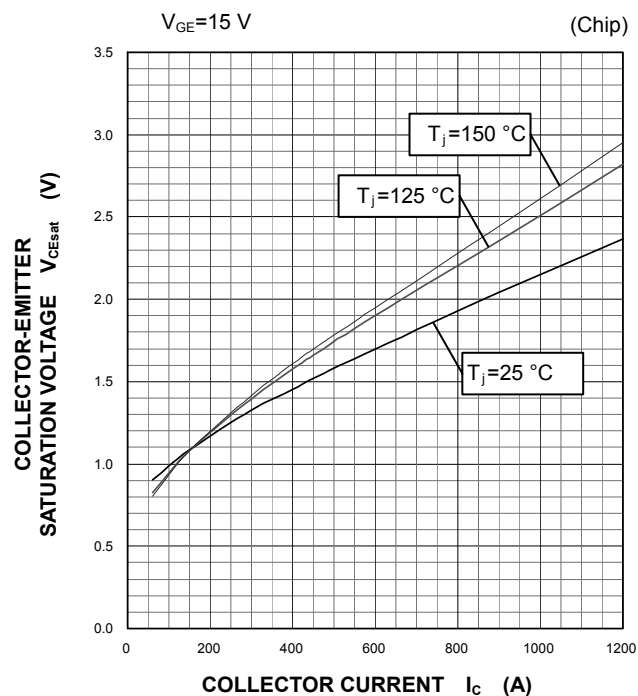
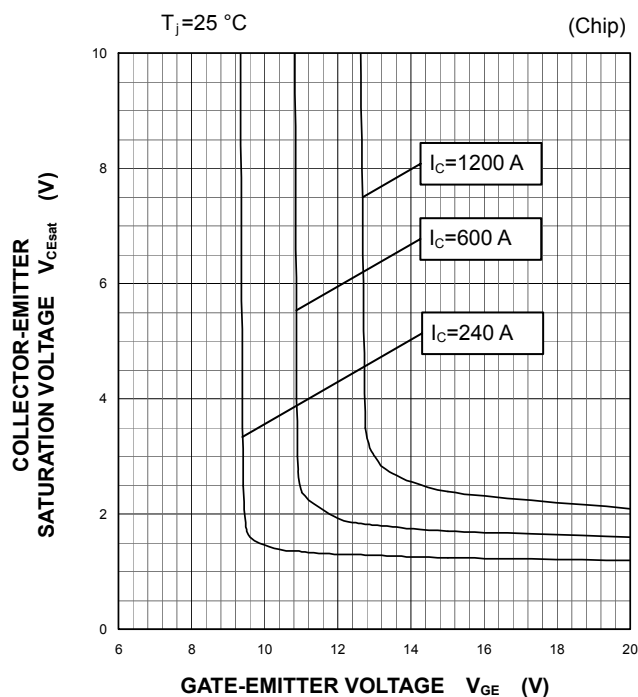
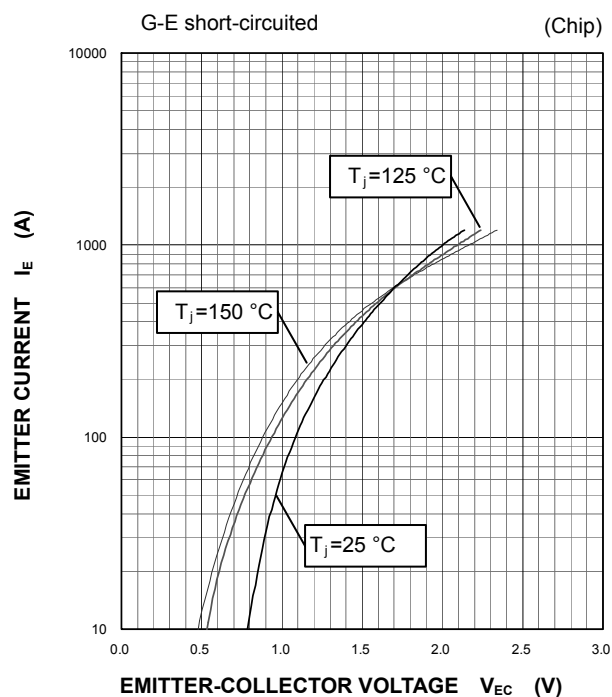
**$V_{EC}$  test circuit**



**Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)**

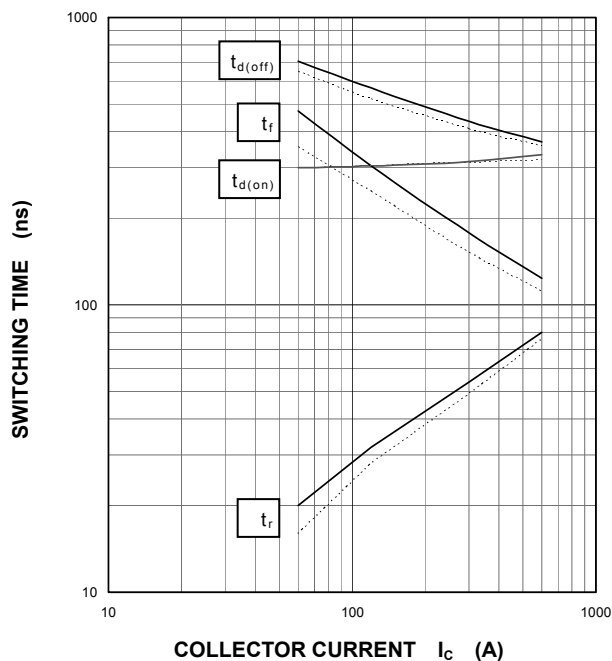
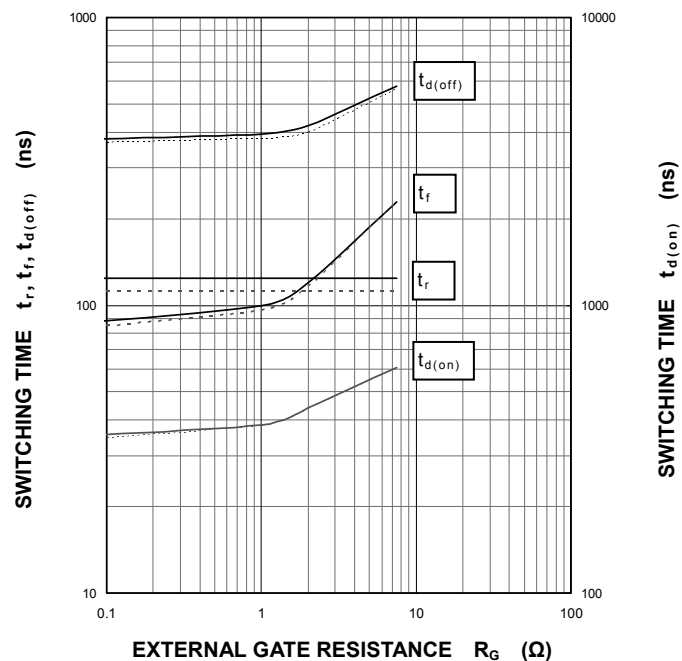
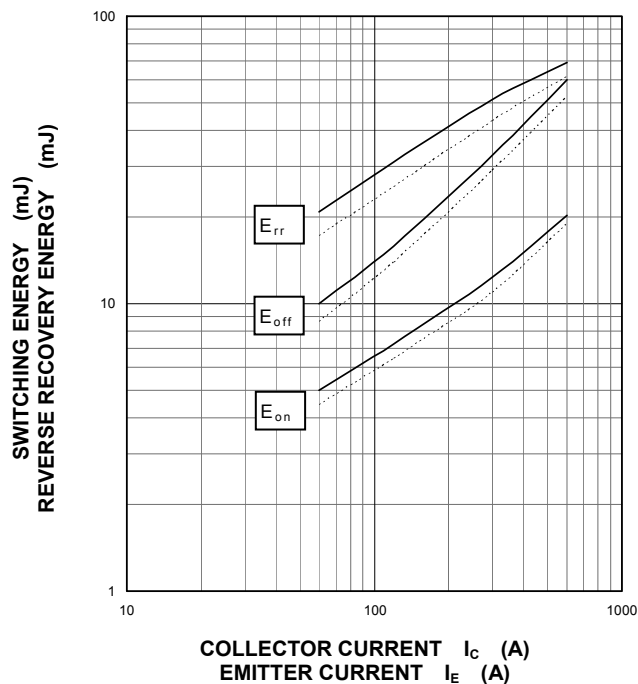
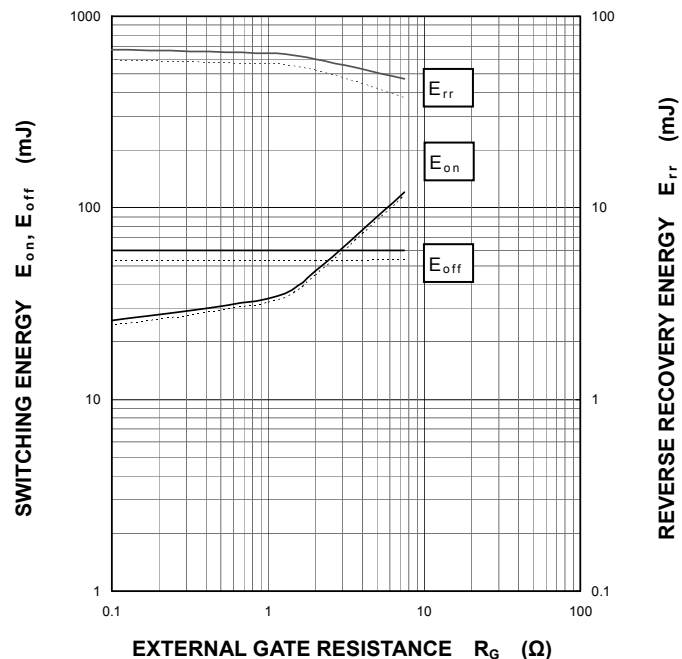
## PERFORMANCE CURVES

## INVERTER PART

OUTPUT CHARACTERISTICS  
(TYPICAL)COLLECTOR-EMITTER SATURATION  
VOLTAGE CHARACTERISTICS  
(TYPICAL)COLLECTOR-EMITTER SATURATION  
VOLTAGE CHARACTERISTICS  
(TYPICAL)FREE WHEELING DIODE  
FORWARD CHARACTERISTICS  
(TYPICAL)

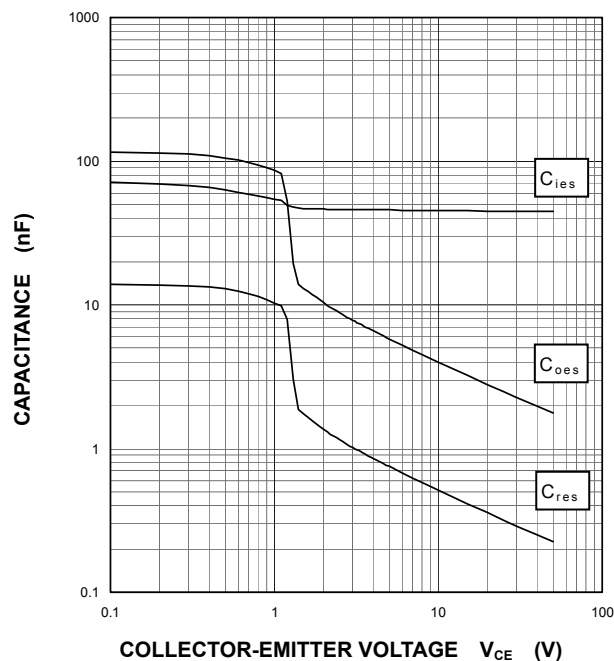
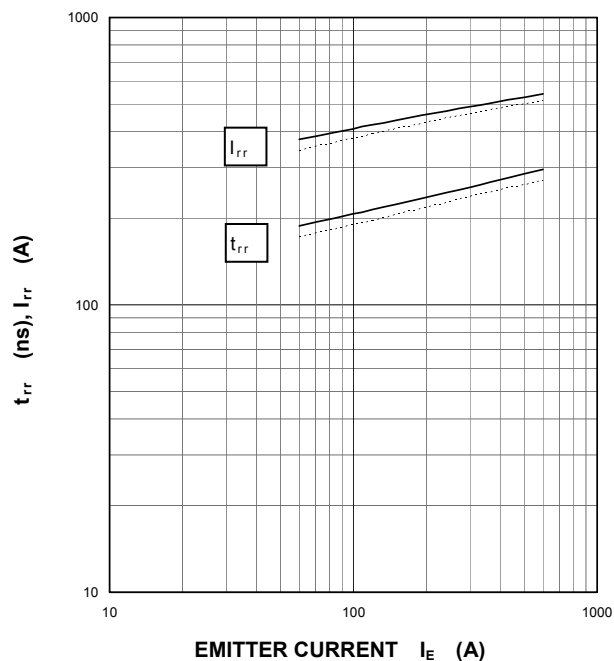
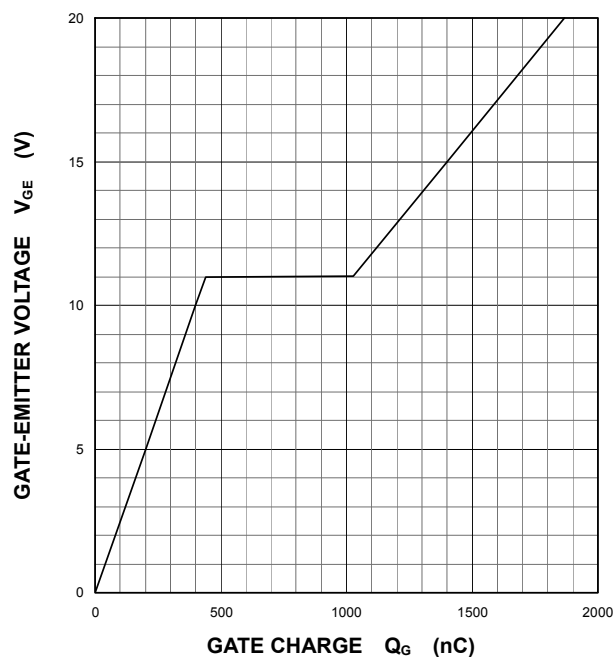
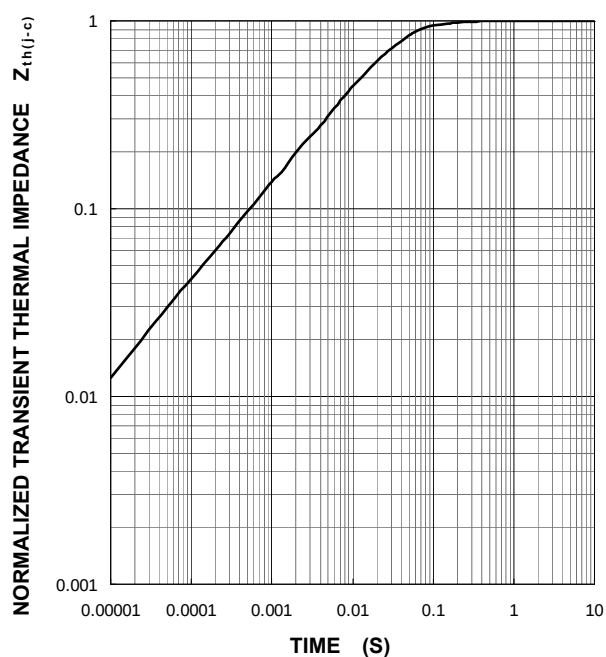
## PERFORMANCE CURVES

## INVERTER PART

HALF-BRIDGE  
SWITCHING CHARACTERISTICS  
(TYPICAL) $V_{CC}=600\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $R_G=0\ \Omega$ , INDUCTIVE LOAD—:  $T_J=150\text{ }^\circ\text{C}$ , - - - - -:  $T_J=125\text{ }^\circ\text{C}$ HALF-BRIDGE  
SWITCHING CHARACTERISTICS  
(TYPICAL) $V_{CC}=600\text{ V}$ ,  $I_C=600\text{ A}$ ,  $V_{GE}=\pm 15\text{ V}$ , INDUCTIVE LOAD—:  $T_J=150\text{ }^\circ\text{C}$ , - - - - -:  $T_J=125\text{ }^\circ\text{C}$ HALF-BRIDGE  
SWITCHING CHARACTERISTICS  
(TYPICAL) $V_{CC}=600\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $R_G=0\ \Omega$ ,  
INDUCTIVE LOAD, PER PULSE—:  $T_J=150\text{ }^\circ\text{C}$ , - - - - -:  $T_J=125\text{ }^\circ\text{C}$ HALF-BRIDGE  
SWITCHING CHARACTERISTICS  
(TYPICAL) $V_{CC}=600\text{ V}$ ,  $I_C/I_E=600\text{ A}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  
INDUCTIVE LOAD, PER PULSE—:  $T_J=150\text{ }^\circ\text{C}$ , - - - - -:  $T_J=125\text{ }^\circ\text{C}$ 

## PERFORMANCE CURVES

## INVERTER PART

CAPACITANCE CHARACTERISTICS  
(TYPICAL)G-E short-circuited,  $T_j=25\text{ }^{\circ}\text{C}$ FREE WHEELING DIODE  
REVERSE RECOVERY CHARACTERISTICS  
(TYPICAL) $V_{CC}=600\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $R_G=0\text{ }\Omega$ , INDUCTIVE LOAD—:  $T_j=150\text{ }^{\circ}\text{C}$ , - - - - :  $T_j=125\text{ }^{\circ}\text{C}$ GATE CHARGE CHARACTERISTICS  
(TYPICAL) $V_{CC}=600\text{ V}$ ,  $I_C=600\text{ A}$ ,  $T_j=25\text{ }^{\circ}\text{C}$ TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS  
(MAXIMUM)Single pulse,  $T_C=25\text{ }^{\circ}\text{C}$  $R_{th(j-c)Q}=33\text{ K/kW}$ ,  $R_{th(j-c)D}=63\text{ K/kW}$ 



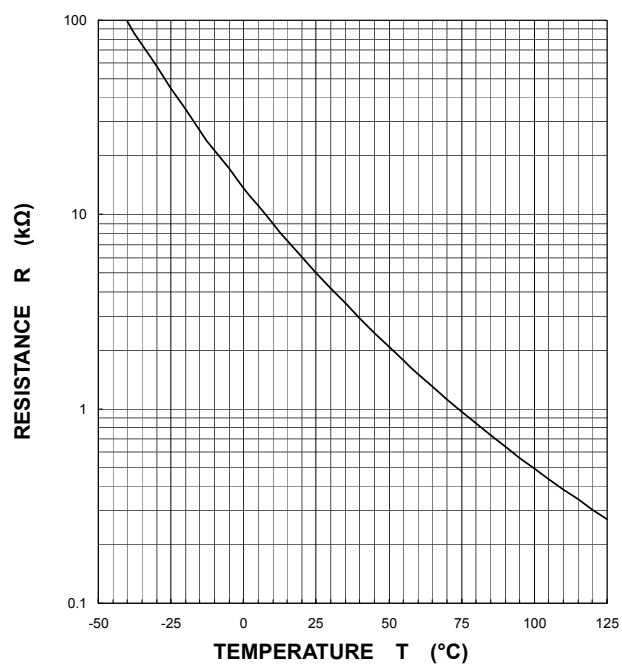
< IGBT MODULES >  
**CM600DXL-24S**  
HIGH POWER SWITCHING USE  
INSULATED TYPE

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**PERFORMANCE CURVES**

NTC thermistor part

**TEMPERATURE CHARACTERISTICS  
(TYPICAL)**



### **Keep safety first in your circuit designs!**

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